

Super Junction MOSFET

N-Channel Super Junction MOSFET

Features

• Drain-Source voltage: V_{DS}=700V (@T_J=150°C)

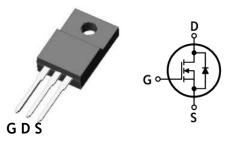
• Low drain-source On resistance: $R_{DS(on)}$ =0.6 Ω (Max.)

• Ultra low gate charge: Qg=13.5nC(Typ.)

RoHS compliant device100% avalanche tested

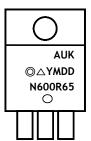
Ordering Information

Part Number	Marking	Package
SJMN600R65F	N600R65	TO-220F-3L



TO-220F-3L

Marking Information



Column 1: Manufacturer

Column 2: Production Information

e.g.) ⊚△YMDD

-. $\bigcirc \triangle$: Factory Management Code

-. YMDD: Date Code (Year, Month, Daily)

Column 3: Device Code

Absolute maximum ratings (T_C=25°C unless otherwise noted)

Characteristic	Symbol		Rating	Unit		
Drain-source voltage		V_{DSS}	650	٧		
Gate-source voltage		V _{GSS} ±30		٧		
Drain current (DC) (Note 1)	I _D	T _c =25°C	7	Α		
Drain current (DC) (Note 1)		T _c =100°C	4.4	Α		
Drain current (Pulsed) (Note 1)		I _{DM}	28	Α		
Single pulsed avalanche energy (Note 2)	E _{AS}		158	mJ		
Repetitive avalanche current (Note 1)	I _{AR}		7	Α		
Repetitive avalanche energy (Note 1)		E _{AR}	3.2	mJ		
Power dissipation	P _D		P _D		32	W
Junction temperature		TJ	150	°C		
Storage temperature range	T _{stg}		-55~150	°C		

^{*} Limited only maximum junction temperature

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Thermal Characteristics

Characteristic	Symbol	Rating	Unit
Thermal resistance, junction to case	$R_{th(j-c)}$	Max. 3.9	°C/W
Thermal resistance, junction to ambient	$R_{th(j\text{-}a)}$	Max. 62.5	C/W

Electrical Characteristics (T_C=25°C unless otherwise noted)

Characteristic	Symbol	Test Condition	Min.	Тур.	Max.	Unit
Drain-source breakdown voltage	BV _{DSS}	I _D =250uA, V _{GS} =0	650	-	-	٧
Gate threshold voltage	$V_{GS(th)}$	I _D =250uA, V _{DS} =V _{GS}	2	3	4	٧
5		V _{DS} =650V, V _{GS} =0V	-	-	1	uA
Drain-source cut-off current	I _{DSS}	V _{DS} =650V, T _J =125°C	-	-	100	uA
Gate leakage current	I _{GSS}	V_{DS} =0V, V_{GS} =±30V	-	-	±100	nA
Drain-source on-resistance	R _{DS(ON)}	V _{GS} =10V, I _D =3.5A	-	-	0.6	Ω
Input capacitance	C _{iss}		-	557	-	
Output capacitance	C _{oss}	$V_{DS}=25V$, $V_{GS}=0V$, $V_{SS}=0V$	-	294	-	pF
Reverse transfer capacitance	C _{rss}		-	17	-	
Turn-on delay time (Note 3)	t _{d(on)}		-	16	-	
Rise time (Note 3)	t _r	V_{DS} =350V, I_{D} =7A,	-	13	-	25
Turn-off delay time (Note 3)	t _{d(off)}	$R_G=25\Omega$	-	35	-	ns
Fall time (Note 3)	t _f		-	7	-	
Total gate charge (Note 4)	Q_{g}		-	13.5	-	
Gate-source charge (Note 4)	Q_{gs}	V_{DS} =400V, V_{GS} =10V, I_{D} =7A	-	4.5	-	nC
Gate-drain charge (Note 4)	Q_{gd}		-	3.5	-	

Source-Drain Diode Ratings and Characteristics (T_C=25°C unless otherwise noted)

Characteristic	Symbol	Test Condition	Min.	Тур.	Max.	Unit
Source current (DC)	I _S	Integral reverse diode	-	-	7	Α
Source current (Pulsed)	I _{SM}	in the MOSFET	-	-	28	Α
Forward voltage	V_{SD}	V_{GS} =0V, I_S =7A	-	-	1.2	٧
Reverse recovery time (Note 3,4)	t _{rr}	I _S =7A, V _{GS} =0V,	-	278	-	ns
Reverse recovery charge (Note 3,4)	Q_{rr}	dl _s /dt=100A/us	-	2	-	uC

Note:

- 1. Calculated continuous current based on maximum allowable junction temperature
- 2. L=7mH, I_{AS} =7A, V_{DD} =50V, Starting T_J =25°C
- 3. Guaranteed by design, not subject to production testing
- 4. Pulse test: Pulse width≤300us, Duty cycle≤2%

Typical Electrical Characteristics Curves

Fig. 1 Typical Output Characteristics

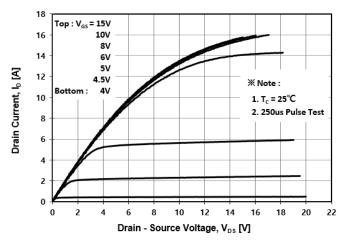


Fig. 2 Typical Transfer Characteristics

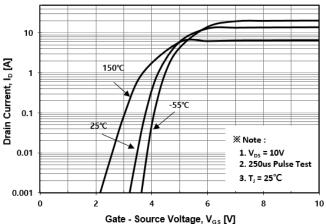


Fig.3 On-Resistance Variation with Drain Current and Gate Voltage

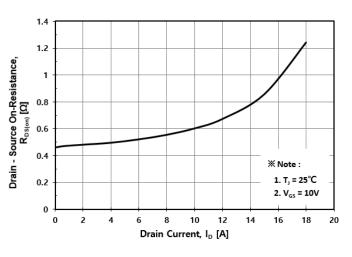


Fig. 4 Body Diode Forward Voltage Variation with Source Current

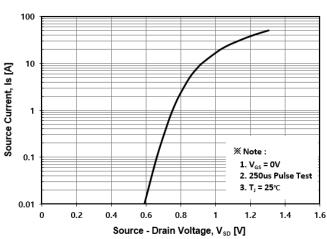


Fig. 5 Typical Capacitance Characteristics

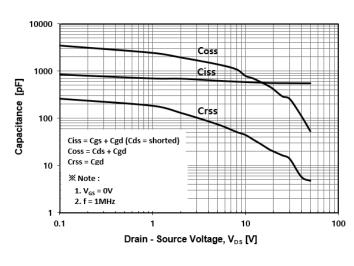


Fig. 6 Typical Total Gate Charge Characteristics

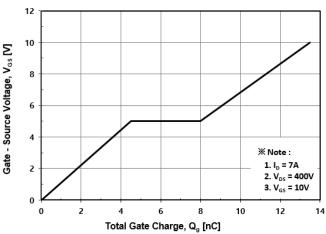


Fig. 7 Breakdown Voltage Variation vs. Temperature

Fig. 8 On-Resistance Variation vs. Temperature

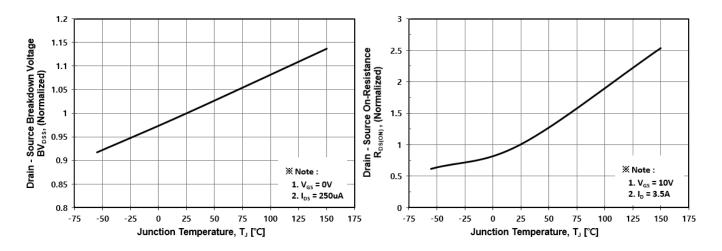


Fig. 9 Maximum Drain Current vs. Case Temperature

Fig. 10 Maximum Safe Operating Area

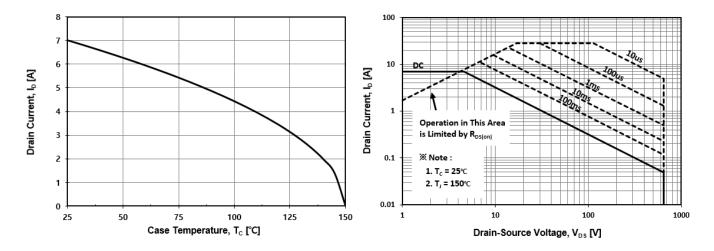
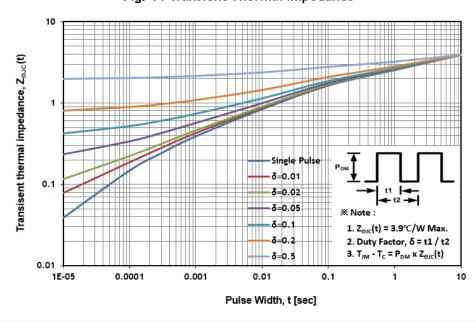
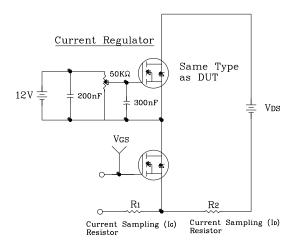


Fig. 11 Transient Thermal Impedance



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Fig. 12 Gate Charge Test Circuit & Waveform



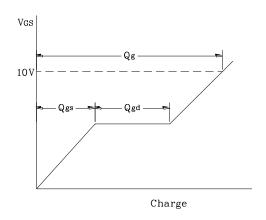
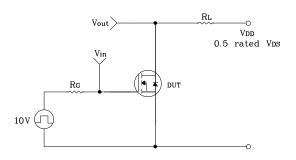


Fig. 13 Resistive Switching Test Circuit & Waveform



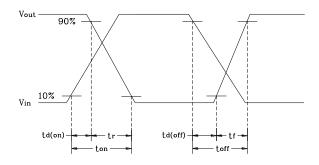
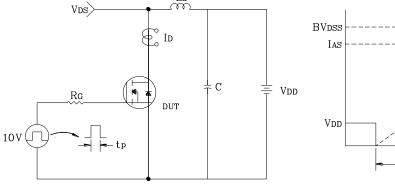


Fig. 14 E_{AS} Test Circuit & Waveform



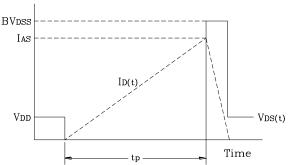
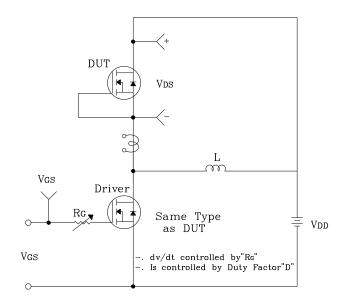
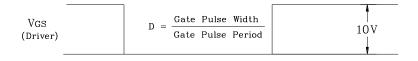
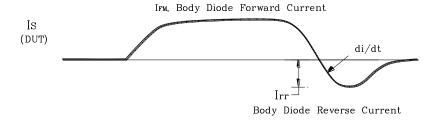
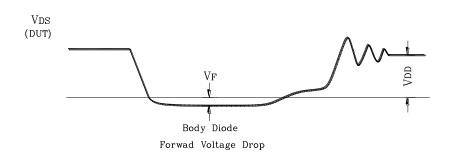


Fig. 15 Diode Reverse Recovery Time Test Circuit & Waveform

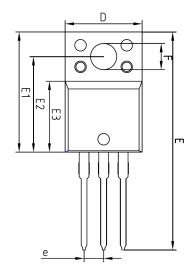


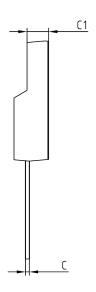


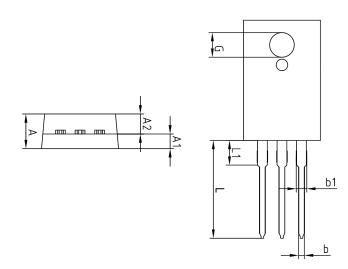




Package Outline Dimensions







		NOTE		
SYMBOL	MINIMUM	NOMINAL	MAXIMUM	NOTE
Α	_	_	4.60	
A1	2.45	2.50	2.55	
A2	1.95	2.00	2.05	
b	0.65	0.75	0.85	
b1	1.07	1.27	1.47	
С	0.40	0.50	0.60	
C1	2.70	2.80	2.90	
D	9.90	10.00	10.10	
Ε	28.00	-	28.60	
E1	15.50	15.60	15.70	
E2	12.30	12.40	12.50	
E3	9.15	9.20	9.25	
F	3.30	3.40	3.50	
G	3.10	3.20 2.54 BS	3.30	
е				
L	12.40	_	13.00	
11				

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